

Exploiting Circuit Duality to Speed Up SAT

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Abstract— In this paper, we establish a *non-trivial duality* between tautology and contradiction check to speed up circuit SAT. Tautology check determines if a logic circuit is *true* in every possible interpretation. Analogously, contradiction check determines if a logic circuit is *false* in every possible interpretation. A *trivial* transformation of a (tautology, contradiction) check problem into a (contradiction, tautology) check problem is the *inversion* of all outputs in a logic circuit. In this work, we show that *exact logic inversion* is not necessary. We give operator switching rules that selectively exchange tautologies with contradictions, and *viceversa*. Our approach collapses into logic inversion just for tautology and contradiction extreme points but generates *non-complementary* logic circuits in the other cases. This property enables computing benefits when an alternative, but equisolvable, instance of a problem is easier to solve than the original one. As a case study, we investigate the impact on SAT. There, our methodology generates a dual SAT instance solvable in parallel with the original one. This concept can be used on top of any other SAT approach and does not impose much overhead, except having to run two solvers instead of one, which is typically not a problem because multi-cores are widespread and computing resources are inexpensive. Experimental results show a 25% speed-up of SAT in a concurrent execution scenario. Also, statistical experiments confirmed that our runtime reduction is not of the random variation type.

I. INTRODUCTION

Inspecting the properties of logic circuits is pivotal to logic applications for computers and especially to *Electronic Design Automation* (EDA) [1]. There exists a large variety of properties to be checked in logic circuits, e.g., *unateness*, *linearity*, *symmetry*, *balancedness*, *monotonicity*, *thresholdness* and many others [2]. Basic characteristics are usually verified first to provide grounds for more involved tests. Tautology and contradiction are the most fundamental properties in logic circuits. A check for tautology determines if a logic circuit is *true* for all possible input patterns. Analogously, a check for contradiction determines if a logic circuit is *false* for all possible input patterns. While investigating elementary properties, tautology and contradiction check are difficult problems, i.e., co-NP-complete and NP-complete, respectively [3]. Indeed, both tautology and contradiction check are equivalent formulation of the Boolean *SATisfiability* (SAT) problem [3]. In this scenario, new efficient algorithms for tautology/contradiction check are key to push further the edge of computational limits, enabling larger logic circuits to be examined.

Tautology and contradiction check are dual problems. One can interchangeably check for tautology in place of contradiction by *inverting* all outputs in a logic circuit. In this *trivial* approach, the two obtained problems are fully complementary and there is no explicit computational advantage in solving one problem instead of the other.

In this paper, we show that *exact logic inversion* is not necessary for transforming tautology into contradiction, and *viceversa*. We give a set of operator switching rules that

selectively exchange tautologies with contradictions. A logic circuit modified by our rules is *inverted* just if identically *true* or *false* for all input combinations. In the other cases, it is not necessarily the complement of the original one. In a simple logic circuit made of AND, OR and INV logic operators, our switching rules swap AND/OR operator types. We give a set of rules for general logic circuits in the rest of this paper. Note that in this paper we mostly deal with single output circuits. For multi-output circuits, the same approach can be extended by ORing (contradiction) or ANDing (tautology) the outputs that need to be checked into a single one.

Our approach generates two different, but equisolvable, instances of the same problem. In this scenario, solving both of them in parallel enables a positive computation speed-up. Indeed, the instance solved first stops the other reducing the runtime. This concept can be used on top of any other checking approach and does not impose much overhead, except having to run two solvers instead of one, which is typically not a problem because multi-cores are wide-spread and computing resources are inexpensive. Note that other parallel checking techniques exist. For example, one can launch in parallel many randomized check runs on the same problem instance with the aim to hit the instance-intrinsic minimum runtime [4]. Instead, in our methodology, we create a different but equi-checkable instance that has a potentially lower minimum runtime. As a case study, we investigate the impact of our approach on SAT. There, by using *non-trivial* and *trivial* dualities in sequence, we create a dual SAT instance solvable in parallel with the original one. Experimental results show 25% speed-up of SAT, on average, in a concurrent execution scenario. Also, statistical experiments confirmed that our runtime reduction is not of the random variation type.

The remainder of this paper is organized as follows. Section II describes some background and discusses the motivation for this study. Section III presents theoretical results useful for the scope of this paper. Section IV proves our main result on the duality between tautology and contradiction check. Section V shows the benefits enabled by this duality in SAT solving. Section VI concludes the paper.

II. BACKGROUND AND MOTIVATION

This section first provides notation on logic circuits. Then, it gives a brief background on tautology checking from an EDA perspective. Finally, it discusses the motivation for this study.

A. Notation

A logic circuit is a *Directed Acyclic Graph* (DAG) representing a Boolean function, with nodes corresponding to logic gates and directed edges corresponding to wires connecting the gates. The *on-set* of a logic circuit is the set of input patterns evaluating to *true*. Analogously, the *off-set* of a logic circuit is the set of input patterns evaluating to *false*. Each

logic gate is associated with a primitive Boolean function taken from a predefined set of *basis* logic operators, e.g., AND, OR, XOR, XNOR, INV, MAJ, MIN etc. Logic operators such as MAJ and MIN represent *self dual* Boolean functions, i.e., functions whose output complementation is equivalent to inputs complementation. A set of *basis* logic operators is said to be *universal*¹ if any Boolean function can be represented by a logic circuit equipped with those logic gates. For example, the *basis* set {OR, INV} is *universal* while the *basis* set {AND, MAJ} is not. Fig.1 shows a logic circuit for the

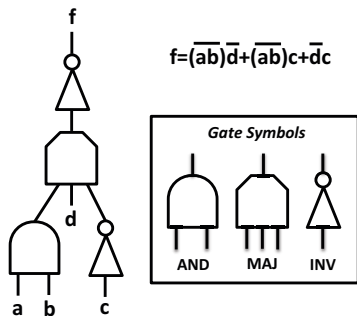


Fig. 1: Logic circuit example representing the function $f = (ab)d + (ab)c + dc$. The *basis* set is {AND, MAJ, INV}. The gates symbolic representation is shown in the box.

function $f = (ab)d + (ab)c + dc$ over the *universal basis* set {AND, MAJ, INV}.

B. Tautology Checking

Tautology checking, i.e., verifying whether a logic circuit is *true* in every possible interpretation, is an important task in computer science and at the core of EDA [5], [7]. Traditionally, tautology checking supports digital design verification through combinational equivalence checking [7]. Indeed, the equivalence between two logic circuits can be detected by XNOR-ing and checking for tautology. Logic synthesis also uses tautology checking to (i) highlight logic simplifications during optimization [5], [6] and to (ii) identify matching during technology mapping [8]. On a general basis, many EDA tasks requiring automated deduction are solved by tautology check routines.

Unfortunately, solving a tautology check problem can be a difficult task. In its most general formulation, the tautology check problem is co-NP-complete. A straightforward method to detect a tautology is the exhaustive exploration of a function truth table. This *naive* approach can declare a tautology only in exponential runtime. More intelligent methods have been developed in the past. Techniques based on cofactoring trees and binary recursion have been presented in [9]. Together with rules for pruning/simplifying the recursion step, these techniques reduced the checking runtime on several benchmarks. Another method, originally targeting propositional formulas, is Stalmarck's method [10] that rewrites a formula with a possibly smaller number of connectives. The derived equivalent formula is represented by triplets that are propagated to check for tautology. Unate recursive cofactoring trees and Stalmarck's method are as bad as any other tautology check method in

¹In this work, the term *basis* does not share the same properties as in linear algebra. In particular, here not all the *basis* are *universal*.

the worst case but very efficient in real-life applications. With the rise of *Binary Decision Diagrams* (BDDs) [11], tautology check algorithms found an efficient canonical data structure explicitly showing the logic feature under investigation [12]. The BDD for a tautology is always a single node standing for the logic constant *true*. Hence, it is sufficient to build a BDD for a logic circuit and verify the resulting graph size (plus the output polarity) to solve a tautology check problem. Unfortunately, BDDs can be exponential in size for some functions (multipliers, hidden-weight bit, etc.). In the recent years, the advancements in SAT solving tools [13], [14] enabled more scalable approaches for tautology checking. Using the *trivial* duality between tautology and contradiction, SAT solvers can be used to determine if an *inverted* logic circuit is unsatisfiable (contradiction) and consequently if the original circuit is a tautology. Still, SAT solving is an NP-complete problem so checking for tautology with SAT is difficult in general.

C. Motivation

Tautology checking is a task surfing the edge of today's computing capabilities. Due to its co-NP-completeness, tautology checking aggressively consumes computational power when the size of the problem increases. To push further the boundary of examinable logic circuits, it is important to study new efficient checking methodologies. Indeed, even a narrow theoretical improvement can generate a speed-up equivalent to several years of technology evolution.

In this paper, we present a *non-trivial* duality between contradiction and tautology check problems that opens up new efficient solving opportunities.

III. PROPERTIES OF LOGIC CIRCUITS

In this section, we show properties of logic circuits with regard to their *on-set/off-set* balance and distribution. These theoretical results will serve as grounds for proving our main claim in the next section.

We initially focus on two *universal basis* sets: {AND, OR, INV} and {MAJ, INV}. We deal with richer *basis* sets later on. We first recall a known fact about majority operators.

Property A MAJ operator of n -variables, with n odd, can be configured as an $\lceil n/2 \rceil$ -variables AND operator by biasing $\lfloor n/2 \rfloor$ inputs to logic *false* and can be configured as an $\lfloor n/2 \rfloor$ -variables OR operator by biasing $\lceil n/2 \rceil$ inputs to logic *true*.

For the sake of clarity, an example of a three-input MAJ configuration in AND/OR is depicted by Fig. 2. Extended

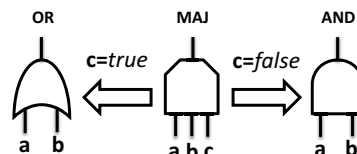


Fig. 2: AND/OR configuration of a three-input MAJ.

at the circuit level, such property enables the emulation of any {AND, OR, INV} logic circuit by a structurally identical {MAJ, INV} logic circuit. This result was previously shown in [15] where logic circuit over the *basis* set {AND, OR, INV} are called AND/OR-INV graphs and logic circuits over

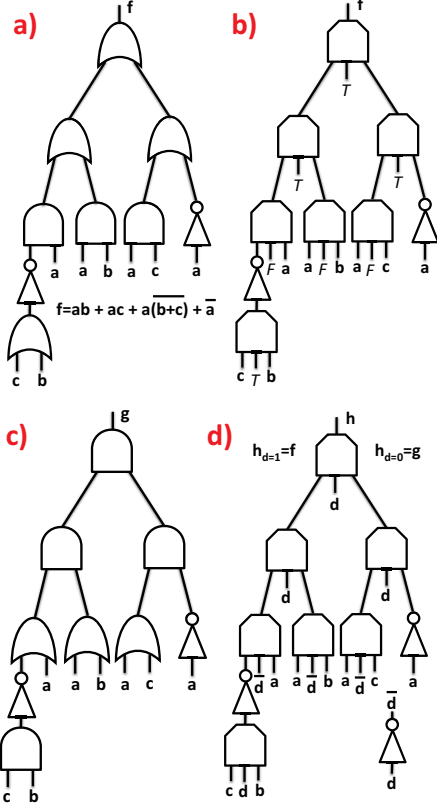


Fig. 3: Logic circuits examples. {AND, OR, INV} logic circuit representing $f = ab + ac + a(b+c) + \bar{a}$ (a). {MAJ, INV} logic circuit emulating the circuit in (a) using constants (b). {AND, OR, INV} logic circuits derived from (a) by switching AND/OR operators (c). {MAJ, INV} logic circuit emulating the circuit in (a) using a fictitious input variable d (d).

the *basis* set {MAJ, INV} are called MAJ-INV graphs. An example of two structurally, and functionally, identical logic circuits over the *basis* sets {AND, OR, INV} and {MAJ, INV} is depicted by Fig. 3(a-b). The Boolean function represented in this example is $f = ab + ac + a(b+c) + \bar{a}$. MAJ are configured to behave as AND/OR by fixing one input to *false*(F)/*true*(T), respectively. In place of biasing one input of the MAJ with a logic constant, it is also possible to introduce a fictitious input variable connected in regular/inverted polarity to substitute *true*(T)/*false*(F) constants, respectively. In this way, the function represented is changed but still including the original one when the fictitious input variable is assigned to *true*. Fig. 3(d) shows a logic circuit with a fictitious input variable d replacing the logic constants in Fig. 3(b). The Boolean function represented there is h with property $h_{d=true} = f$.

Up to this point, we shown that {AND, OR, INV} logic circuits can be emulated by {MAJ, INV} logic circuits configured either by (i) logic constants or by (ii) a fictitious input variable. In the latter case, {MAJ, INV} logic circuits have all inputs assignable. With no logic constants appearing and all operators being *self-dual*, this particular class of logic circuits have a perfectly balanced *on-set/off-set* size. The following theorem formalizes this property.

Theorem 3.1: Logic circuits over the *universal basis* set

{MAJ, INV}, with all inputs assignable (no logic constants), have $|on-set|=2^{n-1}$ and $|off-set|=2^{n-1}$, with n being the number of input variables.

Proof MAJ and INV logic operators, with no constants, represent *self-dual* Boolean functions. In [2], it is shown that *self-dual* Boolean functions have an $|on-set|=|off-set|=2^{n-1}$, with n being the number of input variables. Also, it is shown in [2] that Boolean functions composed by *self-dual* Boolean functions are *self-dual* as well. This is indeed the case for {MAJ, INV} logic circuits with no constants in input. As these circuits represent *self-dual* Boolean functions, we can assert $|on-set|=|off-set|=2^{n-1}$. *Q.E.D.*

{MAJ, INV} logic circuits with no constants have a perfectly balanced partition between *on-set* size and *off-set* size. This is the case for the example in Fig. 3(d). Eventually, we know that by assigning d to *true* in such example circuit the *on-set/off-set* balance can be lost. Indeed, with $d=true$ the {MAJ, INV} logic circuit then emulates the original {AND, OR, INV} logic circuit in Fig. 3(a), that could have different *on-set* size and *off-set* size. Still, it is possible to reclaim the perfect *on-set/off-set* balance by superposing the cases $d=true$ and $d=false$ in the {MAJ, INV} logic circuit. While we know precisely what the {MAJ, INV} logic circuit does when $d=true$, the case $d=false$ is not as evident. We can interpret the case $d=false$ as an inversion in the MAJ configuration polarity. This means that where a MAJ is configured as an AND (OR) node in $d=true$, it is instead configured as an OR (AND) node in $d=false$. In other words, $d=false$ in the {MAJ, INV} logic circuit of Fig. 3(d) corresponds to switch AND/OR operator types in the original {AND, OR, INV} logic circuit of Fig. 3(a). The resulting AND/OR switched circuit is depicted by Fig. 3(c).

United by a common {MAJ, INV} generalization, {AND, OR, INV} logic circuits and their AND/OR switched versions share strong properties about *on-set/off-set* repartition. The following theorem states their relation.

Theorem 3.2: Let A be a logic circuit over the *universal basis* set {AND, OR, INV}. Let A' be a modified version of A , with AND/OR operators switched. The following identities hold $|on-set(A)|=|off-set(A')$ and $|off-set(A)|=|on-set(A')$.

Proof Say M a {MAJ, INV} logic circuit emulating A using an extra fictitious input variable, say d . $M_{d=1}$ is structurally and functionally equivalent to A , while $M_{d=0}$ is structurally and functionally equivalent to A' . From Theorem 3.1 we know that $|on-set(M)|=|off-set(M)|=2^{n-1}=2^m$, where m is the number of input variables in A and n the number of input variables in M , with $n = m + 1$ to take into account the extra fictitious input variable in M . We know by construction that $|on-set(M_{d=1})|+|on-set(M_{d=0})|=2^{m-1}=2^m$ and $|off-set(M_{d=1})|+|off-set(M_{d=0})|=2^{n-1}=2^m$. Again by construction we know that $M_{d=1}$ and $M_{d=0}$ can be substituted by A and A' , respectively, in all equations. Owing to the basic definition of A and A' we have that $|on-set(A)|+|off-set(A)|=2^m$ and $|on-set(A')|+|off-set(A')|=2^m$. Expressing $|on-set(A)|$ as $2^m-|on-set(A')$ from the first set of equations and substituting this term in $|on-set(A)|+|off-set(A)|=2^m$ we get $2^m-|on-set(A')|+|off-set(A)|=2^m$ that can be simplified as $|off-set(A)|=|on-set(A')$. This proves the first identity of the Theorem. The second identity can be proved analogously.

Q.E.D.

Informally, the previous theorem says that by switching AND/OR operators in an {AND, OR, INV} logic circuit we swap the *on-set* and *off-set* sizes. From a statistical perspective, this is equivalent to invert $Pr(A=true)$ with $Pr(A=false)$, under uniformly random input string of bits. While this also happens with *exact logic inversion*, here the actual distribution of the *on-set/off-set* elements is not necessarily complementary. In the next section, we show the implications of the theoretical results seen so far in tautology and contradiction check problems.

IV. FROM TAUTOLOGY TO CONTRADICTION AND BACK

Verifying whether a logic circuit is a tautology, a contradiction or a contingency² is an important task in logic applications for computers.

In this section, we show that tautology and contradiction check in logic circuits are dual and interchangeable problems that do not require *exact logic inversion per se*. We start by considering logic circuit over the *universal basis* set {AND, OR, INV} and we consider richer *basis* sets later on. The following theorem describes the *non-trivial* duality between tautology and contradiction in {AND, OR, INV} logic circuits.

Theorem 4.1: Let A be a logic circuit over the *universal basis* set {AND, OR, INV} representing a tautology (contradiction). The logic circuit A' , obtained by switching AND/OR operations in A , represents a contradiction (tautology).

Proof If A represents a tautology then $|on-set(A)|=2^m$ and $|on-set(A)|=0$, with m being the number of inputs. Owing to Theorem 3.2 $|on-set(A')|=|off-set(A)|=0$ and $|off-set(A')|=|on-set(A)|=2^m$. It follows that A' is a contradiction. Analogous reasoning holds for contradiction to tautology transformation. Q.E.D.

Switching AND/ORs in an {AND, OR, INV} logic circuit is strictly equivalent to logic inversion only for tautology and contradiction. In the other cases, A and A' are not necessarily complementary. We give empirical evidences about this fact hereafter. Fig. 4 depicts the obtained results in a graph chart. We examined 17 random Boolean functions of four input variables, with *on-set size* ranging from 0 (contradiction) to 16 (tautology). We first compared the *on-set size* of the real inverted logic circuits with the *on-set size* of the AND/OR switched circuits. As expected, Theorem 3.2 holds and switching AND/OR operators results in exchanging the *on-set* and *off-set* sizes. This also happens with the real inverted circuits, but in that case also the actual *on-set/off-set* elements distribution is complementary. To verify what is the *on-set/off-set* elements distribution in general, we define a distance metric between the real inverted and AND/OR switched circuits. The distance metric is computed in two steps. First, the truth tables of the circuits are unrolled, using the same input order, and represented as binary strings. Second, the distance metric is measured as the Hamming distance³ between those binary strings. For tautology and contradiction extremes the distance metric between AND/OR switched circuits and real inverted

²A logic circuit is a contingency when it is neither a tautology nor a contradiction [2]

³The Hamming distance between two binary strings, of equal size, is the number of positions at which the corresponding bits are different.

4-Variables AND/OR-switched vs. Real Inverted Logic Circuits

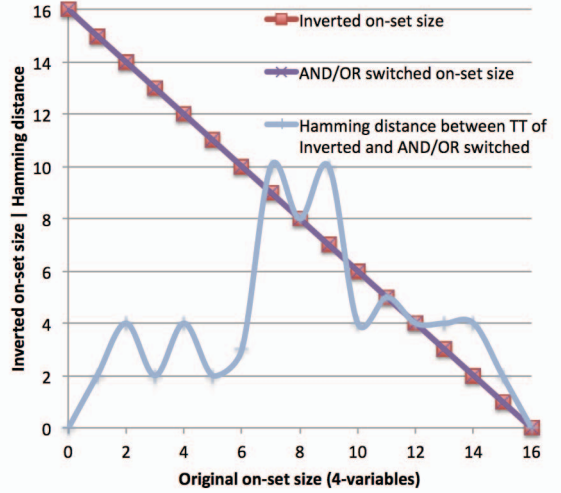


Fig. 4: Comparison between *real inverted* and *AND/OR switched* logic circuits representing 4-variable Boolean functions. The *on-set* size ranges from 0 to 2^4 .

circuits is 0, as obvious consequence of Theorem 4.1. For other circuits, real inverted and AND/OR switched circuits are different, with distance metric ranging between 2 and 10.

As a practical interpretation of the matter discussed so far, we can get an answer for a tautology (contradiction) check problem by working on a functionally different and *non-complementary* structure than the original one under test. We explain hereafter why this fact is interesting. Suppose that the logic circuit we want to check is a contingency but algorithms for tautology (contradiction) are not efficient on it. If we just invert the outputs of this logic circuit and we run algorithms for contradiction (tautology) then we would likely face the same difficulty. However, if we switch AND/ORs in the logic circuit we get a functionally different and *non-complementary* structure. In this case, algorithms for contradiction (tautology) do not face by construction the same complexity. Exploiting this property, it is possible to speed-up a traditional tautology (contradiction) check problem. Still, Theorem 4.1 guarantees that if the original circuit is a tautology (contradiction) then the AND/OR switched version is a contradiction (tautology) preserving the checking correctness.

Recalling the example in Fig. 3(a), the original logic circuit represents a tautology. Consequently, the logic circuit in Fig. 3(c) represents a contradiction. These properties are verifiable by hand as the circuits considered are small. For an example which is a *contingency*, consider the {AND, OR, INV} circuit realization for $f = ab' + c'$ (contingency). By switching AND/ORs, we get $g = (a + b')c'$ which is different from both f or f' , as predicted.

We now consider logic circuits with richer *basis* set functions than just {AND, OR, INV}. Our enlarged *basis* set includes {AND, OR, INV, MAJ, XOR, XNOR} logic operators. Other operators can always be decomposed into this *universal basis* set, or new switching rules can be derived. In the following, we extend the applicability of Theorem 4.1.

Theorem 4.2: Let A be a logic circuit over the *universal basis* set {AND, OR, INV, MAJ, XOR, XNOR} representing a tautology (contradiction). The logic circuit A' , obtained by

TABLE I: Switching Rules for Tautology/Contradiction Check

Original Logic Operator	Switched Logic Operator
INV	INV
AND	OR
OR	AND
MAJ	MAJ
XOR	XNOR
XNOR	XOR

switching logic operators in A as per Table I, represents a contradiction (tautology).

Proof In order to prove the theorem, we need to show the switching rules just for XOR, XNOR and MAJ operators. AND/OR switching is already proved by Theorem 4.1. Consider the XOR operator decomposed in terms of {AND, OR, INV}: $f = a \oplus b = ab' + a'b$. Applying the duality in Theorem 4.1 we get $g = (a + b')(a' + b)$ that is indeed equivalent to a XNOR operator. This proves the XOR to XNOR switching and *viceversa*. Analogously, consider the MAJ operator decomposed in terms of {AND, OR, INV}: $f = ab + ac + bc$. Applying the duality in Theorem 4.1 we get $g = (a + b)(a + c)(b + c)$ that is still equivalent to a MAJ operator. Hence, MAJ operators do not need to be modified. *Q.E.D.*

Note that in a data structure for a computer program, the operator switching task does not require actual pre-processing of the logic circuit. Indeed, each time that a node in the DAG is evaluated an external flag word determines if the regular or switched operator type has to be retrieved from memory.

In the current section, we shown a *non-trivial* duality between contradiction and tautology check. In the next section, we study its application on Boolean satisfiability.

V. EXPERIMENTAL RESULTS

In this section, we exercise our *non-trivial* duality in Boolean *SAT*isfiability (SAT) problems. First, we describe how to use the tautology/contradiction duality to generate a second (dual) equisatisfiable SAT instance. Second, we demonstrate that the dual instance can be solved faster than the regular one and the corresponding runtime reduction is not of the random variation type. Third, and last, we show experimental results for a concurrent regular/dual SAT execution scenario.

A. Boolean SAT and Tautology/Contradiction Duality

The Boolean SAT problem consists of determining whether there exists or not an interpretation evaluating to *true* a Boolean formula or circuit. The Boolean SAT problem is reciprocal to a check for contradiction. When contradiction check fails then Boolean SAT succeeds while when contradiction check succeeds then Boolean SAT fails. Instead of checking for Boolean SAT or for contradiction, one can use a dual transformation in the circuit and check for tautology. Such transformation can be either (i) *non-trivial*, i.e., switching logic operators in the circuit as per Table I or (ii) *trivial*, i.e., output complementation. If we use twice any dual transformation, we go back to the original problem domain (contradiction, SAT). Note that if we use twice the same dual transformation (*trivial-trivial* or *non-trivial-non-trivial*) we obtain back exactly the original circuit. Instead, if we apply two different dual transformations in sequence (*trivial-non-trivial* or *non-trivial-trivial*) we obtain an equisatisfiable but not necessarily equivalent circuit. We use the latter approach

to generate a second equisatisfiable circuit, which we call the dual circuit. The dual circuit SAT can be solved in parallel with the regular one in a "first finishing wins" speculative strategy. Fig. 5 depicts the corresponding flow. We generate the

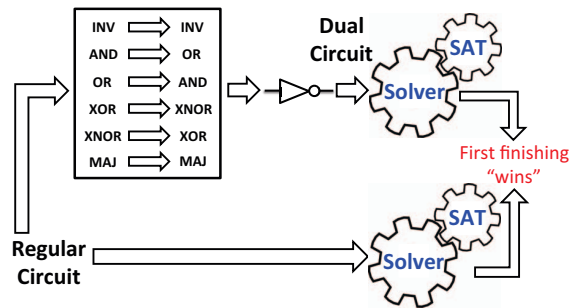


Fig. 5: Speculative parallel regular/dual circuit SAT flow.

dual circuit by first applying our *non-trivial duality* (switching rules in Table I) and finally complementing the outputs (*trivial duality*). Note that these operations ideally require no (or very little) computational overhead, as explained previously.

B. Verification of SAT Solving Advantage on the Dual Circuit

In our first set of experiments we focused on verifying whether the dual circuit can be easier to satisfy than the regular circuit. For this purpose, we modified MiniSat-C v1.14.1 [16] to read circuits in AIGER format [18] and to encode them in CNF internally via Tseitin transformation. The dual circuit is generated online during reading if a switch "-p" is given. We considered a large circuit (0.7 M nodes) over 1000 randomized (pseudo-random number generator seed) runs. Fig. 6 shows the runtime distributions for dual and regular SAT. The

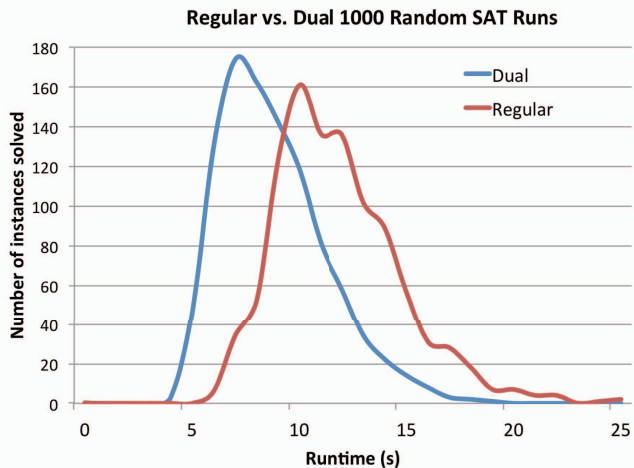


Fig. 6: 1000 randomized SAT runs for regular and dual circuit.

dual runtime distribution is clearly left-shifted (but partially overlapping) with respect to the regular runtime distribution. This confirms that (i) the dual circuit can be solved faster than the regular one and (ii) the runtime reduction is not of the random variation type.

C. Results for Concurrent Regular/Dual SAT Execution

In our second set of experiments (downloadable at [19]) we used ABC tool [17] to test our dual approach together

TABLE II: Experimental Results for Regular vs. Dual SAT Solving
All runtimes are in seconds

Benchmark	I/O	Logic Size	Logic Depth	Runtime Regular	Runtime Dual	Δ Runtime	Best Runtime
hardsat1	4580/1	283539	392	186.35	58.9	127.35	58.9
hardsat2	4580/1	287635	392	51.1	191.87	140.77	51.1
hardsat3	198540/1	920927	267	0.94	1.1	0.16	0.94
hardsat4	2452/1	43962	436	68.82	20.53	48.29	20.53
hardsat5	5725/1	562027	464	40.91	22.72	18.19	22.72
hardsat6	3065/1	86085	437	37.51	64.24	26.73	37.51
hardsat7	372240/1	85596	151	4.8	3.68	1.12	3.68
Total <i>sat</i>	591182/7	2269771	2539	390.43	363.04	27.39	195.38
hardunsat1	61/1	448884	2181	26.72	27.22	0.50	26.72
hardunsat2	61/1	264263	2951	3.70	1.32	2.38	1.32
hardunsat3	61/1	451350	2181	27.8	20.33	7.47	20.33
hardunsat4	540/1	244660	1158	234.88	326.84	91.96	234.88
hardunsat5	2352/1	208221	439	7.61	7.65	0.04	7.65
hardunsat6	550/1	117820	423	142.28	137.94	4.34	137.94
Total <i>unsat</i>	3625/6	1735198	9333	442.99	521.30	78.31	428.80
Total	594807/13	4004969	11872	833.42	884.34	50.84	624.18
Norm. to Regular	–	–	–	1.00	1.06	–	0.75

with advanced techniques to speed-up SAT. Our custom set of benchmarks is derived by (i) unfolding SAT sequential problems (ii) encoding combinational equivalence check problems. All benchmarks are initially described in Verilog as a netlist of logic gates over the *basis* {AND, OR, INV, XOR, XNOR, MAJ}. The dual circuits are obtained by applying switching rules in Table I and inverting the output. The ABC script to read and run SAT on these benchmarks is: `read library.genlib; r -m input.v; st; write out.aig; &r out.aig; &ps; &write_cnf -K 4 out.cnf; dsat -p out.cnf`. Apart from standard I/O commands, note that `&write_cnf -K 4 out.cnf` generates a CNF using a technology mapping procedure and `dsat -p` calls MiniSat with variable polarity alignment.

Table II shows results for regular vs. dual SAT solving with our setup. For about half of the benchmarks (7/13) the dual instance concluded first while for the remaining ones (6/13) the regular instance was faster. The total regular runtime is quite close to the total dual runtime (just 6% of deviation). However, considering here the speculative parallel SAT flow in Fig. 5, we can ideally reduce the total runtime by about 25%. Note that this is an ideal projection into a parallel execution environment, with no overhead. We experimentally verified that the average overhead can be small (few percentage points) thanks to the intrinsic independence of the two tasks.

VI. CONCLUSIONS

In this paper, we have shown a *non-trivial* duality between tautology and contradiction check to speed up circuit SAT. On the one hand, tautology check determines if a logic circuit is *true* for all input combinations. On the other hand, contradiction check determines if a logic circuit is *false* for all input combinations. A *trivial* transformation of a (tautology, contradiction) check problem into a (contradiction, tautology) check problem is the *inversion* of all the outputs in a logic circuit. In this work, we proved that *exact* logic inversion is not necessary. By switching logic operator types in a logic circuit, following the rules presented in this paper, we can selectively exchange tautologies with contradictions. Our approach is equivalent to logic inversion just for tautology and contradiction extreme points. It generates *non-complementary* logic circuits in the other cases. Such property enables computing benefits when an alternative but equisolvable instance is easier to solve than the original one. As a case study, we

studied the impact on SAT. There, our methodology generated a dual SAT instance solvable in parallel with the original one. This concept can be used on top of any other SAT approach and does not impose much overhead, except having to run two solvers instead of one, which is typically not a problem because multi-cores are wide-spread and computing resources are inexpensive. Experimental results shown 25% speed-up of SAT in a concurrent execution scenario.

ACKNOWLEDGEMENTS

This work was supported by grant ERC-2009-AdG-246810.

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